

Notice of References Cited

Application/Control No.

09/939,922

Applicant(s)/Patent Under

Reexamination

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Examiner

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,835,624 /	05-1989	Black et al.	360/2
	B	US-6,527,638 /	03-2003	Walker et al.	463/25
	C	US-5,871,398 /	02-1999	Schneier et al.	463/16
	D	US-6,024,640 /	02-2000	Walker et al.	463/17
	E	US-5,475,205 /	12-1995	Behm et al.	235/375
	F	US-6,270,406 /	08-2001	Sultan, Hashem	463/17
	G	US-6,190,256 /	02-2001	Walker et al.	463/25
	H	US-6,048,269 /	04-2000	Burns et al.	463/25
	I	US-4,858,123 /	08-1989	Alexoff et al.	101/484
	J	US-6,012,832 /	01-2000	Saunders et al.	235/375
	K	US-4,689,742 /	08-1987	Troy et al.	463/25
	L	US-5,321,568 /	06-1994	Hatam-Tabrizi, Shahab	360/245.1
	M	US-5,595,538 /	01-1997	Haste, III, Thomas E.	463/17

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 9416781 A1 /	08-1994	World Intellect	BURNS et al.	A63B 71/06
	O	WO 9524689 A1 /	09-1995	World Intellect	WALKER, JAY	G06F155/00
	P	WO 9859311 A1 /	12-1998	World Intellect	SAUNDERS et al.	G06K 05/00
	Q	DE 3406058 A1 /	08-1985	Germany	BISCHOFBERGER, JOSEPH	G07F 11/00
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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